

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination HAN ET AL.	
		Examiner Shawntina T. Fuqua	Art Unit 3742	Page 1 of 1

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*	C	US-3,154,004	10-1964	HUCK ALFRED J	99/390
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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